S = 17 %



Application/Control No.	Applicant(s)/Patent under Reexamination
10/720,647	COBLEY ET AL.
Examiner	Art Unit
Lois Zheng	1742

SEARCHED				
Class	Subclass	Date	Examiner	
204	242	5/24/2006	LLZ	
106	1.12-1.15	5/24/2006	LLZ	
106	1.18-1.19	5/24/2006	LLZ	
106	1.21	5/24/2006	LLZ	
205	125	5/24/2006	LLZ	
205	291-292	5/24/2006	LLZ	
205	297-298	5/24/2006	LLZ	
			-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARC (INCLUDING SEA	H NOTES ARCH STRATEGY)
	DATE	EXMR
Inventorship Search	5/24/2006	LLZ
EAST	5/24/2006	LLZ